Amendments to the Claims:

The following listing of claims replaces all prior listings, and all prior versions, of claims in the application:

Listing of Claims:

1. (Currently Amended) An encapsulating solid epoxy resin molding material, comprising (A) an epoxy resin, (B) a curing agent, and (C) an inorganic filler a silica, wherein (C) the inorganic filler (C)silica has a maximum diameter size of at least 32 μm, an average particle size of 12 μm or less and a specific surface area of 3.0 m²/g or more, and

wherein (C) the silica satisfies the following conditions: the amount of particles having a particle size of 12 µm or less is 50% or more by weight; the amount of particles having a particle size of 24 µm or less is 70% or more by weight; and the amount of particles having a particle size of 32 µm or less is 80% or more by weight; the amount of particles having a particle size of 48 µm or less is 90% or more by weight.

2. (Currently Amended) An encapsulating solid epoxy resin molding material, comprising (A) an epoxy resin, (B) a curing agent, and (C) an inorganic filler silica, wherein (C) the inorganic filler (C)silica comprises 5% or more by weight of an inorganic filler silica having a maximum particle size of 63 μm or less and particle sizes of 20 μm or more.

3. (Cancelled)

- 4. (Currently Amended) An encapsulating solid epoxy resin molding material, comprising (A) an epoxy resin, (B) a curing agent, and (C) an inorganic filler, and satisfying at least eneall of the following conditions: the glass transition temperature based on TMA method is 150°C or higher; the bending modulus based on JIS-K 6911 is 19 GPa or less; and the mold shrinkage ratio based on JIS-K 6911 is 0.2% or less.
- 5. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claims 1 to 4claim 1, wherein the melt density viscosity of the epoxy resin (A) is 2 poises or less at 150°C.
- 6. (Currently amended) The encapsulating <u>solid</u> epoxy resin molding material according to <u>any one of claims 1 to 4 claim 1</u>, wherein the epoxy resin (A) comprises at least <u>enone</u> of a biphenyl epoxy resin, a bisphenol F epoxy resin, a stylbene epoxy resin, a sulfur-containing epoxy resin, a Novolak epoxy resin, a dicyclopentadiene epoxy resin, a naphthalene epoxy resin and a triphenylmethane epoxy resin.
- 7. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claims 1 to 4 claim 1, wherein the melt density viscosity of the curing agent (B) is 2 poises or less at 150°C.
- 8. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claim 1 to 4 claim 1, wherein the curing agent (B) comprises

at least one of a biphenyl phenol resin, an aralkyl phenol resin, a dicyclopentadiene phenol resin, a triphenylmethane phenol resin, and a Novolak phenol resin.

9. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claims 1 to 4 claim 1, further comprising a curing accelerator (F).

10. (Cancelled)

- 11. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claims 1 to 3claim 1, wherein the average particle size of (C) the inorganic filler (C)silica is 10 µm or less.
- 12. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claims 1 to 3 claim 1, wherein the specific surface area of (C) the inorganic filler (C)silica is from 3.5 to 5.5 m²/g.
- 13. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claims 1 to 4 claim 1, further comprising a coupling agent(D).
- 14. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 13, wherein the coupling agent (D) comprises (D2) a silane coupling agent having a secondary amino group.

15. (Currently amended) The encapsulating solid epoxy resin molding material according to claim 14, wherein the silane coupling agent (D2), which has the secondary amino group, comprises a compound represented by the following general formula (I):

$$\begin{array}{c} R^{1} \\ NH \\ CH_{2} \\ \end{array} \begin{array}{c} Si \\ CR^{3} \\ \end{array} \begin{array}{c} M \\ \end{array}$$
 (I)

wherein R¹ is selected from a hydrogen atom, an alkyl group having 1 to 6 carbon atoms, and an alkoxy group having 1 to 2 carbon atoms, R² is selected from an alkyl group having 1 to 6 <u>carbon atoms</u>, and a phenyl group, R³ represents a methyl or ethyl group, n represents an integer of 1 to 6, and m represents an integer of 1 to 3.

- 16. (Currently amended) The encapsulating solid epoxy resin molding material according to any one of claims 1 to 4 claim 1, further comprising a phosphorus compound (E).
- 17. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 16, wherein the phosphorus compound (E) comprises a phosphate.
- 18. (Currently amended) The encapsulating solid epoxy resin molding material according to claim 17, wherein the phosphate comprises a compound represented by the following general formula (II):

wherein eight R's, which may be the same or different, each represent an alkyl group having 1 to 4 <u>carbon atoms</u>, and Ar represents an aromatic ring.

- 19. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 16, wherein the phosphorus compound (E) comprises phosphine oxide.
- 20. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 19, wherein the phosphine oxide comprises a compound represented by the following general formula (III):

$$R_1$$
— P — R_3 (III) R_2

wherein R^1 , R^2 and R^3 , which may be the same or different, each represent a substituted or unsubstituted alkyl group having 1 to 10 carbon atoms, an aryl group, an aralkyl group, or a hydrogen atom provided that the case that all of R^1 , R^2 and R^3 are hydrogen atoms is excluded.

21. and 22. (Cancelled)

- 23. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 13, wherein the filler coverage ratio of the coupling agent (D) is from 0.3 to 1.0.
- 24. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 13, wherein the heating reduction loss ratio after heating at 200°C/hour is 0.25% or less by weight.
- 25. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 23, wherein the heating reduction loss ratio after heating at 200°C/hour is 0.25% or less by weight.

26. and 27. (Cancelled)

- 28. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 4, wherein the warp of a semiconductor device is 5.0 mm or less.
- 29. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 4, wherein the warp of a semiconductor device is 2.0 mm or less.

- 30. (Currently Amended) The encapsulating solid epoxy resin molding material according to claim 4, wherein the content by percentage of the inorganic filler (C) is from 70 to 90% by weight of the epoxy resin molding material.
- 31. (Currently Amended) A semiconductor device encapsulated by an encapsulating solid epoxy resin molding material comprising (A) an epoxy resin, (B) a curing agent, and (C) an inorganic filler.

32.-35. (Cancelled)